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U. S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE Complete if Known 10/082,850 Application Number Filing Date February 25, 2002 INFORMATION DISCLOSURE Applicant(s) Kiran, et al. STATEMENT BY APPLICANT (use as many sheets as necessary) Art Unit 2468 2 Examiner Name Unknown

Attorney Docket Number

26530.65

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Examiner Signature	Jacquer Veillard	Date Considered	2/18/05	
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